Notice of References Cited Application/Control No. 10/599,429 Examiner Eileen P. Morgan Applicant(s)/Patent Under Reexamination IIYOSHI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,206,766 B1	03-2001	Schuller, Richard	451/259
*	В	US-6,368,198 B1	04-2002	Sung et al.	451/443
*	С	US-6,419,574 B1	07-2002	Takahashi et al.	451/548
*	D	.US-2002/0127962 A1	09-2002	Cho et al.	451/443
*	Е	US-2004/0029511 A1	02-2004	Kincaid et al.	451/526
*	F	US-2004/0072510 A1	04-2004	Kinoshita et al.	451/056
*	G	US-6,926,598 B2	08-2005	Toge et al.	451/540
*	Н	US-7,021,995 B2	04-2006	Toge et al.	451/56
*	ļ	US-7,066,795 B2	06-2006	Balagani et al.	451/285
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country .	Name	Classification
	N					
	0					
	Р					
	Q			·		
	R				:	
	s					
	Т					

NON-PATENT DOCUMENTS

_	,						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w.						
	×						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.